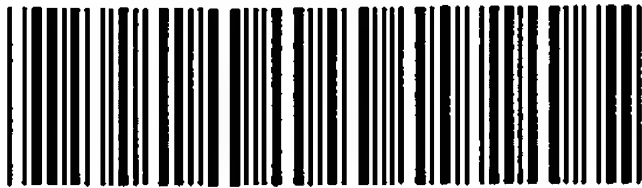


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/665,476	ECHIZENYA, KIYOYUKI	
	Examiner	Art Unit	
	Christopher W. Fulton	2859	

SEARCHED			
Class	Subclass	Date	Examiner
033	1B 1BB 562 563 566	3/9/2005	CWF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR